

Search Notes**Application/Control No.**

10/626,984

Examiner

Leon J. Harper

**Applicant(s)/Patent under
Reexamination**

KAWAI ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	200,104.1, 1,10,8,6,5, 4	3/2/2006	LJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR